

SSC8L60PN6

N-Channel Enhancement Mode MOSFET

> Features

V _{DS}	V _{GS}	R _{DS(ON)} Typ.	ID
COV/	1 201/	1.6mΩ@10V	1604
60V	±20V	2.4mΩ@4.5V	160A

Description

This device is N-Channel enhancement MOSFET.

Uses SGT technology and design to provide excellent

RDSON with low gate charge. This device is suitable
for use in DC-DC conversion, power switch and
charging circuit.

100% UIS + ΔVDS + Rg Tested!

Applications

- DC/DC Conversion
- Power Supplies
- Motor Drive Control
- Synchronous Rectification

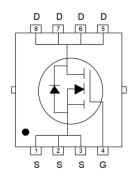
> Ordering Information

Device	Package	Shipping	
SSC8L60PN6	PDFN5X6-8L	5000/Reel	

Pin Configuration



PDFN5X6-8L (Top View)



Pin Configuration



(XXYY: Internal Traceability Code)



➤ Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit		
V _{DSS}	Drain-to-Source Voltage		60	V	
V _{GSS}	Gate-to-Source Volta	Gate-to-Source Voltage		V	
	Continuous Dunin Commant d	T _C =25℃	160	Δ.	
l _D	Continuous Drain Current d	T _C =100℃	85	A	
	Outliness Paris Commits	T _A =25℃	43	Δ.	
IDSM	I _{DSM} Continuous Drain Current ^a	T _A =70°C	31	A	
Ірм	Pulsed Drain Curren	Pulsed Drain Current b			
5		Tc=25℃	83	10/	
P _D	Power Dissipation ^c	bltage $T_{C}=25^{\circ}C$ $T_{C}=100^{\circ}C$ $T_{A}=25^{\circ}C$ $T_{A}=70^{\circ}C$ Tent b $T_{C}=100^{\circ}C$ $T_{C}=100^{\circ}C$ $T_{A}=25^{\circ}C$ $T_{A}=70^{\circ}C$ $T_{A}=70^{\circ}C$ al H Single Pulse $T_{C}=100^{\circ}C$ $T_{C}=100^{\circ$	33	W	
	David Divide the C	Continuous Drain Current a $T_A=70^{\circ}\text{C}$ Pulsed Drain Current b $T_C=25^{\circ}\text{C}$ Power Dissipation c $T_C=100^{\circ}\text{C}$ Power Dissipation a $T_A=25^{\circ}\text{C}$	5.9	10/	
P _{DSM}	Power Dissipation ^a	T _A =70°C	3.8	W	
las	Avalanche Current ^b L=0.5mH Single Pulse		40	Α	
Eas	Avalanche Energy ^b L=0.5mH Single Pulse		400	mJ	
TJ	Operation junction temperature		-55~150	°C	
Тѕтс	Storage temperature ra	ange	-55~150	$^{\circ}\!\mathbb{C}$	

➤ Thermal Resistance Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
Reja	Junction-to-Ambient Thermal Resistance a	21	°C/W
R _{θJC}	Junction-to-Case Thermal Resistance	1.5	C/VV

Note:

- a. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz.copper, in a still air environment with T_A=25°C. The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

SSC-V1.2 www.sscsemi.com Analog Future



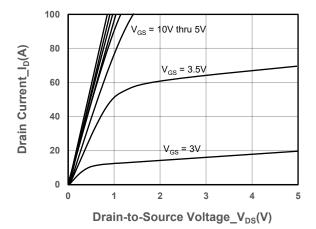


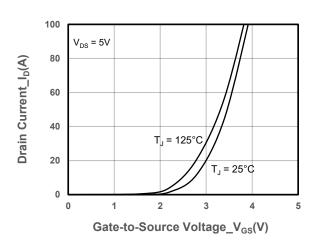
\succ Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	60			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{D} = 250uA$	1.0	1.5	2.5	V
Desir Course On Besistense	R _{DS(on)}	V _{GS} = 10V, I _D = 30A		1.6	2.2	0
Drain-Source On-Resistance		V _{GS} = 4.5V, I _D = 20A	2.4 3.2		3.2	mΩ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 60V, V _{GS} = 0V			1	μΑ
Gate-Source Leak Current	Igss	V _{GS} = ±20V, V _{DS} = 0V			±100	nA
Transconductance	G _{FS}	V _{DS} = 5V, I _D = 20A		37		S
Forward Voltage	V _{SD}	V _{GS} = 0V, I _S = 20A		0.8	1.3	V
Gate Resistance	R _G	V _{DS} = 0V, f = 1MHz		2.5		Ω
Input Capacitance	Ciss	V 00V V 0V		5029		
Output Capacitance	Coss	$V_{DS} = 30V, V_{GS} = 0V,$		825		pF
Reverse Transfer Capacitance	Crss	f = 1MHz		56		
Total Gate Charge	Q _G	101/1/ 001/		85		
Gate to Source Charge	Q _G s	$V_{GS} = 10V, V_{DS} = 30V,$		19		nC
Gate to Drain Charge	Q _{GD}	- I _D = 20A		15		
Turn-on Delay Time	$T_{D(ON)}$			19		
Rise Time	Tr	$V_{GS} = 10V, R_L = 2.5\Omega$		31		
Turn-off Delay Time	T _{D(OFF)}	V_{DS} = 30V, R_{G} = 3 Ω		63		ns
Fall Time	T _f			23		
Diode Recovery Time	Trr	I _F =20A, di/dt=500A/us		34		ns
Diode Recovery Charge	Q _{rr}	I _F =20A, di/dt=500A/us		70		nC

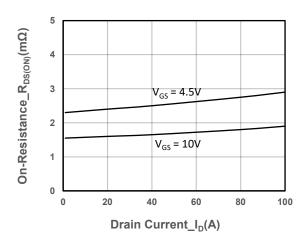


> Typical Performance Characteristics (T_A=25℃ unless otherwise noted)

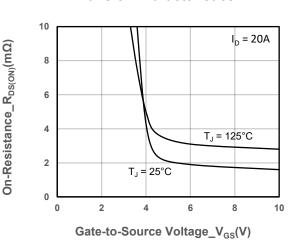




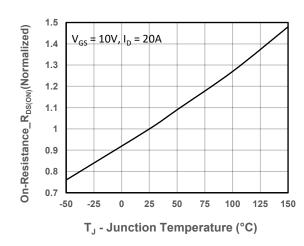
Output Characteristics



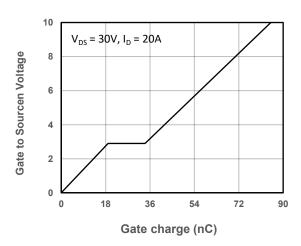
Transfer Characteristics



On-Resistance vs. Drain Current and Gate Voltage



On-Resistance vs. Gate-to-Source Voltage

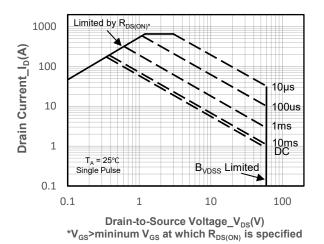


On-Resistance vs. Junction Temperature

Gate-Source Voltage vs. Gate charge

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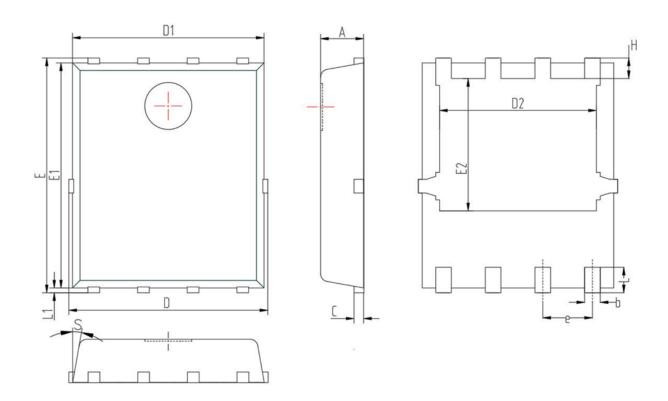




Safe Operating Area vs. Junction-to-Ambient



Package Information



Cumbal	MILL IMETER			
Symbol	Min	Nom	Max	
А	0.90	1.05	1.20	
b	0.25	0.30	0.51	
С	0.15	0.25	0.35	
D	4.80	5.10	5.40	
D1	4.80	5.00	5.20	
D2	3.70	4.00	4.30	
E	5.80	6.15	6.50	
E1	5.50	5.75	5.95	
E2	3.30	3.45	3.67	
е	1.27BSC			
Н	0.40	0.60	0.93	
L	0.45	0.65	0.85	
L1	0.00	0.10	0.25	
S	0°		12°	



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